

TEST REPORT

Application No.: SHCR2604000943AT
Applicant: Hyperice, Inc.
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Manufacturer: Hyperice, Inc.
Address of Manufacturer: 525 Technology Drive, Suite 100, Irvine, CA, 92618, USA
Factory:
1. Zhejiang E-Cozy Electronic Technology Co., Ltd.
2. Fujian Xiefeng Footware Company Limited
Address of Factory:
1. Building 12, 355 Binhai 12 Branch Road, Wenzhouwan, Wenzhou city, Zhejiang Province, China
2. No. 888 Chenghan West Road, XI Tian Wei Twon, Licheng District, Putian, Fujian, China
Equipment Under Test (EUT):
EUT Name: Nike Zoom Hyperslide
Model No.: HSP001
Trade Mark: Hyperice / Nike
Standard(s) : MIC Item 19 of Article 2 Paragraph 1
Test Method : MIC Notice No.88 Appendix No.43
Date of Receipt: 2026-04-17
Date of Test: 2026-04-18 to 2026-05-15
Date of Issue: 2026-06-01

Test Result:	Pass*
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* In the configuration tested, the EUT complied with the standards specified above.

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Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Member of the SGS Group (SGS SA)

Revision Record			
Version	Description	Date	Remark
00	Original	2026-06-01	/

Authorized for issue by:			
Tested By		Wade Zhang	
		Wade Zhang/Project Engineer	
Approved By		Parlam Zhan	
		Parlam Zhan/Reviewer	

2 Test Summary

Radio Spectrum Technical Requirement				
Item	Standard	Method	Requirement	Result
Antenna Requirement	MIC Item 19 of Article 2 Paragraph 1	N/A	MIC Item 19 of Article 2 Paragraph 1	Pass
Interference prevention capability		MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
RF accessibility		N/A	MIC Item 19 of Article 2 Paragraph 1	Pass

Radio Spectrum Matter Part				
Item	Standard	Method	Requirement	Result
Frequency Error	MIC Item 19 of Article 2 Paragraph 1	MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Occupied Bandwidth(99%)		MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Antenna Power		MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Spurious emission Intensity		MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass
Limit of secondary radiated emissions		MIC Notice No.88 Appendix No.43	MIC Item 19 of Article 2 Paragraph 1	Pass

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4 General Information

4.1 Details of E.U.T.

Power supply:	DC 3.7V, 1.2Ah rechargeable battery
Test Voltage:	DC 3.7V
Operation Frequency:	2402MHz to 2480MHz
Modulation Type:	GFSK
Channel Spacing:	2MHz
Number of Channels:	40
Antenna Type:	PCB Antenna
Antenna Gain:	-1.77dBi(Provided by manufacturer)
Rated Power:	1.5~1.6mW (1Mbps), 1.4~1.5mW (2Mbps)

4.2 Test Conditions

EUT Power by DC 3.7V

The RF unit is supplied DC 3.30V. The fluctuation of input voltage to the circuit of RF unit of test equipment is under $\pm 1\%$, when input voltage from DC3.7V to the test equipment is fluctuated by $\pm 10\%$, So, all measurement has been conducted by only rated voltage.

The measurement result of the voltage fluctuation at RF circuit when DC3.7V +/- 10%.	
DC Input	DC
DC3.7V	3.30V
DC4.07V	3.31V(+0.3%)
DC3.33V	3.29V(-0.3%)

5-35.0 °C

45-85 % RH

1000 -1010 mbar

Note:

VN: Normal Voltage

TN: Normal Temperature

TL: Low Extreme Test Temperature

TH: High Extreme Test Temperature

If the EUT can be set to 3 or more different (carrier) frequencies in 1 allocated band, testing shall be performed using the Lowest, Middle and the Highest frequency (L, M and H). If there are 2 or fewer frequencies, testing shall be performed with the available frequencies.

4.3 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
Laptop	LENOVO	L460	-
SecureCRT	VanDyke	V 6.2.0	-
Serial port adapter plate	-	Test Plate 3	-

4.4 Measurement Uncertainty & Decision Rule

No.	Item	Measurement Uncertainty
1	Radio Frequency	8.4×10^{-8}
2	Timeout	2s
3	Duty cycle	0.4%
4	Occupied Bandwidth	3%
5	RF conducted power	0.6dB
6	RF power density	2.9dB
7	Conducted Spurious emissions	0.75dB
8	RF Radiated power	5.2dB (Below 1GHz) 5.9dB (Above 1GHz)
9	Radiated Spurious emission test	4.2dB (Below 30MHz) 4.5dB (30MHz-1GHz) 5.1dB (1GHz-6GHz) 5.4dB (6GHz-18GHz)
10	Temperature test	1°C
11	Humidity test	3%
12	Supply voltages	1.5%
13	Time	3%

Note: The measurement uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

4.5 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. E&E Lab

588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China

Tel: +86 21 6191 5666 Fax: +86 21 6191 5678

No tests were sub-contracted.

Note:

1. SGS is not responsible for wrong test results due to incorrect information (e.g. max. clock frequency, highest internal frequency, antenna gain, cable loss, etc) is provided by the applicant. (if applicable).
2. SGS is not responsible for the authenticity, integrity and the validity of the conclusion based on results of the data provided by applicant. (if applicable).
3. Sample source: sent by customer.

4.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• **A2LA (Certificate No. 6332.01)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. is accredited by the American Association for Laboratory Accreditation(A2LA).

• **ISED (CAB Identifier: CN0020)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. EMC Laboratory has been recognized by Innovation, Science and Economic Development Canada (ISED) as an accredited testing laboratory.

Company Number: 8617A

• **VCCI (Member No.: 3061)**

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-13868, C-14336, T-12221, G-10830 respectively.

4.7 Deviation from Standards

None

4.8 Abnormalities from Standard Conditions

None

5 Equipment List

Equipment	Manufacturer	Model No	Serial No	Cal Date	Cal Due Date	Cal body	Certifier
Spectrum Analyzer	Agilent	N9020A	MY49100060	2025/07/30	2026/07/29	JEPSI*	(c)
Spectrum Analyzer	Keysight	N9020B	MY58100087	2025/12/17	2026/12/16	JEPSI*	(c)
Signal Generator	R&S	SMR20	101113	2025/07/30	2026/07/29	JEPSI*	(c)
Signal Generator	Agilent	N5182A	MY50143776	2025/07/30	2026/07/29	JEPSI*	(c)
Communication Tester	R&S	CMW270	101162	2025/05/22	2026/05/21	JEPSI*	(c)
Switcher+ Power Sensor	Tonscend / Keysight	JS0806 U2021XA*4	JS0806-2	2025/07/30	2026/07/29	JEPSI*	(c)
EMI Test Receiver	R&S	ESU40	100109	2025/12/17	2026/12/16	JEPSI*	(c)
High-low Temp Cabinet	Suzhou Zhihe	TL-40	20090917	2025/11/05	2026/11/04	SGS SHCAL	(c)
AC Power Stabilizer	APC	KDF-31020T-V0-F0	F317060067	2025/12/17	2026/12/16	JEPSI*	(c)
DC Power Supply	HP	6010A	SHEM222-1	2025/12/17	2026/12/16	JEPSI*	(c)

Remark:

- (a) Calibration conducted by the National Institute of Information and Communications Technology (NICT) in Japan (hereinafter referred to as "NICT") or a designated calibration agency under Article 102-18 paragraph (1) in JRL.
- (b) Correction conducted pursuant to the provisions of Article 135 or Article 144 of the Measurement Act (Act No. 51 of 1992) .
- (c) Calibration conducted in countries except Japan, which shall be equivalent to the calibration conducted by the NICT or a designated calibration agency under Article 102-18 paragraph (1).
- (d) Calibration, etc. conducted by using measuring instruments and other equipment listed in the right column of appended table No. 3, which shall have been given any type of calibration, etc. listed above from (a) to (c).

From JRL Article 24-2, paragraph 4, Item 2

Notice:

- 1) (C) is applicable for equipment calibration above.
- 2) Calibration duration for above equipments is 1 year.

6 Radio Spectrum Technical Requirement

6.1 Antenna Requirement

6.1.1 Test Requirement:

MIC Item 19 of Article 2 Paragraph 1

6.1.2 Conclusion

Standard requirement:

Applicable for equipment with an antenna terminal, including testing terminals. If an antenna connector is available, all relevant tests will be carried out conducted. If not, tests will be carried out in an anechoic room or with a suitable test-fixture.

EUT Details:

The antenna is PCB antenna and no consideration of replacement.

The best case gain of the antenna is -1.77dBi.

Result:

An antenna connector is available, all relevant tests will be carried out conducted.

6.2 Interference prevention capability

6.2.1 Test Requirement:

MIC Item 19 of Article 2 Paragraph 1

Limit:

Article 2, Item (19) Notice 88 Appendix 43

The EUT shall be constructed in such a way that sensitive RF parts, (like modulation and oscillator parts) cannot be reached easily by the user. These parts shall be covered by soldered metal caps or glue or by other mechanical covers. If the covers are fixed with screws, these shall be not the common type(s) like a Phillips, but special versions like Torx, so that the user cannot open the device with common tools.

6.2.2 Conclusion

Standard Requirement:

- 1) Measurement system diagram as shown above and test equipment keep transmitting identification code.
- 2) Condition of measuring instrument
 - (1) Demodulator must be able to demodulate the transmitting signal emitted by test equipment and to indicate the identification code.
- 3) Condition of test equipment The mode of normal use.
- 4) Measuring operation procedure
 - (1) When test equipment has the function to transmit identification code automatically:
 - A) Transmit the predetermined identification code from test equipment.
 - B) Confirm the transmitted identification code by demodulator.

EUT Details:

The unit does meet the requirements (Good).

Mac Address: DA:9D:C0:C7:60:E4

Hyperslide

DA:9D:C0:C7:60:E4

6.3 RF accessibility

6.3.1 Test Requirement:

MIC Item 19 of Article 2 Paragraph 1

6.3.2 Conclusion

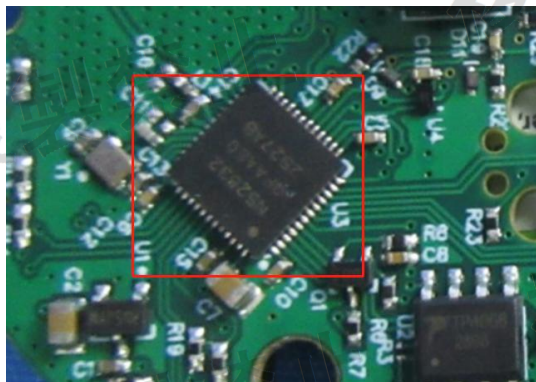
Standard Requirement:

The EUT shall be constructed in such a way that sensitive RF parts, (like modulation and oscillator parts) cannot be reached easily by the user. These parts shall be covered by soldered metal caps or glue or by other mechanical covers. If the covers are fixed with screws, these shall be not the common type(s) like a Phillips, but special versions like Torx, so that the user cannot open the device with common tools.

Protective Structure:

☐	1.Sealed with special screws.
☐	2.Plastic chassis is being welded using ultrasonic waves.
☐	3.Chassis is glued using a special adhesive.
☐	4.Metal covers are spot-fused.
☐	5.Cover is specially interlocked
☐	6.RF and Modulation components are covered with shielding case and this shielding case is soldered.
☐	7.Shield case is welded at RF and modulation parts, and ID-ROM is welded using the BGA Method.
☐	8.Shield case is welded at RF and modulation parts, and ID-ROM is glued at its lead with a special adhesive.
☐	9.Shield case is welded at RF and modulation parts, and ID-ROM is glued with a non-transparent laminating agent.
☒	10.RF and Modulation parts are mounted on PCB with surface mount technology, and there is no any adjustable parts on PCB or adjustable parts are not exposed.

EUT Details:



7 Radio Spectrum Matter Test Results

7.1 Frequency Error

Test Requirement MIC Item 19 of Article 2 Paragraph 1
 Test Method: MIC Notice No.88 Appendix No.43
 Limit: Tolerance of frequency: $\pm 50E-6$

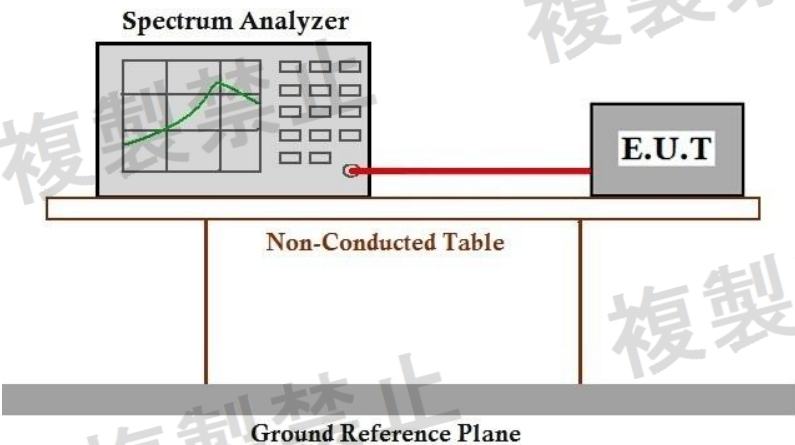
7.1.1 E.U.T. Operation

Operating Environment:
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1010 mbar

7.1.2 Test Mode Description

Pre-scan / Final test	Mode Code	Description
Final test	02	TX mode_Keep the EUT in continuously transmitting mode with GFSK modulation

7.1.3 Test Setup Diagram



7.1.4 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping OFF, CW Tx

3. Spectrum Analyzer conditions:

Frequency: Test Frequency

Span 1MHz

RBW 10 kHz (Modulation OFF),

VBW 10 kHz (Modulation OFF),

Sweep Time Auto

Detector mode Positive peak

Indication mode Max hold

Alternative method:

Frequency: Test Frequency

Span 2 times channel bandwidth

RBW 100 kHz (Modulation ON),

VBW 100 kHz (Modulation ON),

Sweep Time Auto

Detector mode Positive peak

Indication mode Max hold

Please Refer to Appendix for Details

7.2 Occupied Bandwidth(99%)

Test Requirement MIC Item 19 of Article 2 Paragraph 1

Test Method: MIC Notice No.88 Appendix No.43

Limit:

FH: 83.5MHz or less

FH + DS: 83.5MHz or less

FH + OFDM: 83.5MHz or less

OFDM: 40MHz or less

DS: 26MHz or less

Others: 26MHz or less

7.2.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C

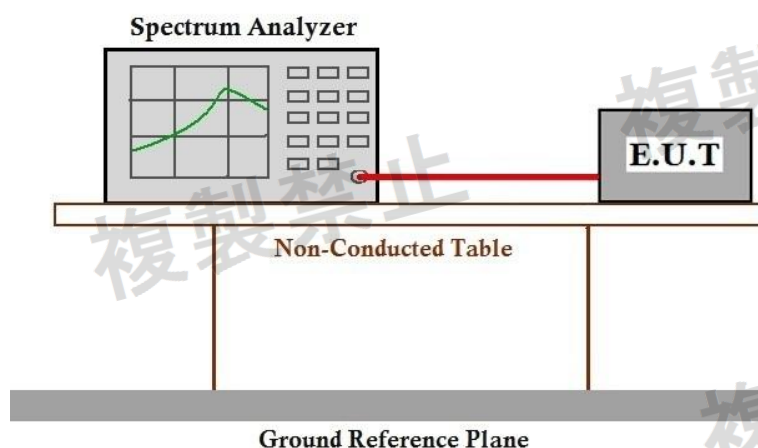
Humidity: 50 % RH

Atmospheric Pressure: 1010 mbar

7.2.2 Test Mode Description

Pre-scan / Final test	Mode Code	Description
Final test	02	TX mode Keep the EUT in continuously transmitting mode with GFSK modulation

7.2.3 Test Setup Diagram



7.2.4 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping ON, Modulation Tx

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

3. Spectrum Analyzer conditions:

Frequency: Test Frequency

Span 83.5 MHz (FHSS); 40/60 MHz (OFDM; DSSS); 2-5 times OBW (Others)

RBW 1 MHz (FHSS); 300kHz (OFDM; DSSS); 3% OBW (Others)

VBW 1 MHz (FHSS); 300kHz (OFDM; DSSS); 3 times RBW (Others)

Sweep Time Auto

detector mode Positive peak

Indication mode Max hold

OBW 99%

Please Refer to Appendix for Details

7.3 Antenna Power

Test Requirement MIC Item 19 of Article 2 Paragraph 1
 Test Method: MIC Notice No.88 Appendix No.43

Limit:
 Designated value
 (1) FH, FH+DS, FH+OFDM: 3mW/MHz
 (used in the range of 2427 - 2470.75 MHz)
 (2) OFDM, DS other than (1) 10mW/MHz
 (3) Other than (1) & (2) 10mW
 (4) OFDM OBW 26 - 40MHz: 5mW/MHz
 Tolerance: +20%, -80%

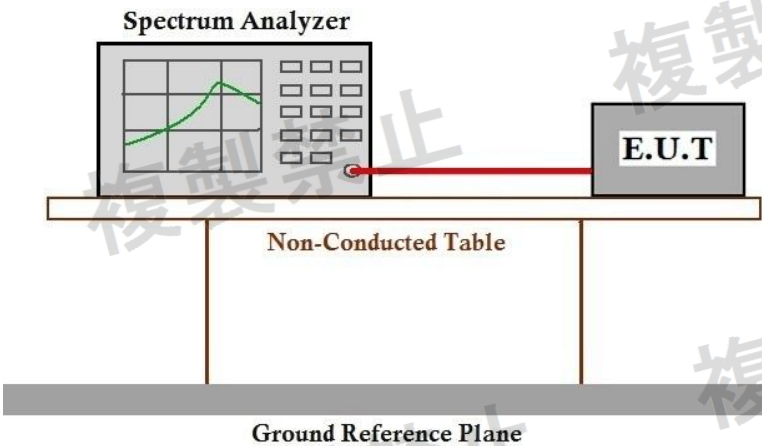
7.3.1 E.U.T. Operation

Operating Environment:
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1010 mbar

7.3.2 Test Mode Description

Pre-scan / Final test	Mode Code	Description
Final test	02	TX mode_ Keep the EUT in continuously transmitting mode with GFSK modulation

7.3.3 Test Setup Diagram



7.3.4 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping ON, Modulation Tx

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

3. Spectrum Analyzer conditions:

Frequency: Test Frequency

Span 25 MHz(FHSS); 40/60 MHz (OFDM; DSSS); Enough to capture the emission (Others)

RBW 1 MHz (FHSS; OFDM; DSSS); More than OBW (Others)

VBW 1 MHz (FHSS; OFDM; DSSS); More than RBW (Others)

Sweep Time Auto

detector mode RMS

Indication mode Max hold

Please Refer to Appendix for Details

7.4 Spurious emission Intensity

Test Requirement MIC Item 19 of Article 2 Paragraph 1

Test Method: MIC Notice No.88 Appendix No.43

Limit:

(1) Below 2387 MHz: 2.5 μ W/MHz

(2) 2387 to 2400 MHz: 25 μ W/MHz

(3) 2483.5 through 2496.5 MHz: 25 μ W/MHz

(4) Over 2496.5 MHz: 2.5 μ W/MHz

7.4.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C

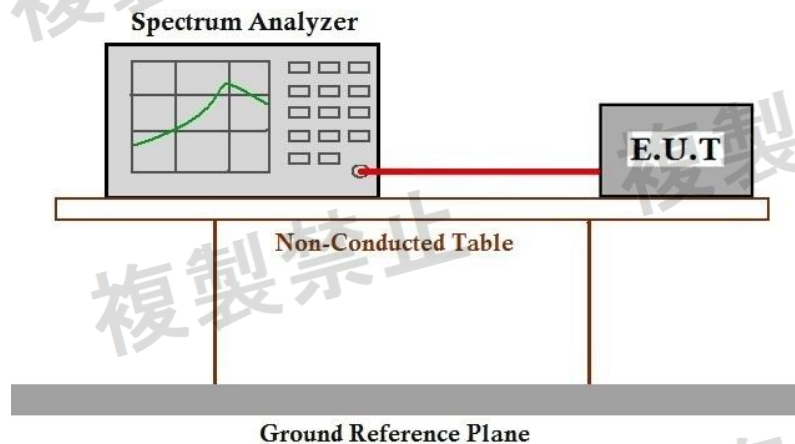
Humidity: 50 % RH

Atmospheric Pressure: 1010 mbar

7.4.2 Test Mode Description

Pre-scan / Final test	Mode Code	Description
Final test	02	TX mode_Keep the EUT in continuously transmitting mode with GFSK modulation

7.4.3 Test Setup Diagram



7.4.4 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping ON, , Modulation Tx

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

3. Spectrum Analyzer conditions:

Step 1

All spurious are measured from 30 MHz to 13 GHz by peak mode.

Step 2

IF the value measured by Step1 is 2 dB or less, measure in average mode.

Test setup for Step 1:

Frequency: 30 MHz - 2400 MHz , 2483.5 MHz -13 GHz

RBW 1 MHz

VBW 1 MHz

Sweep Time Auto

detector mode Positive peak

Indication mode Max hold

Test setup for Step 2:

Frequency: Spurious Frequency

RBW 1 MHz

VBW 1 MHz

Sweep Time Auto

detector mode Sample

Indication mode Max hold

Please Refer to Appendix for Details

7.5 Limit of secondary radiated emissions

Test Requirement MIC Item 19 of Article 2 Paragraph 1

Test Method: MIC Notice No.88 Appendix No.43

Limit:

(1) Below 1 GHz : 4 nW or less

(2) 1 GHz and over : 20 nW or less

7.5.1 E.U.T. Operation

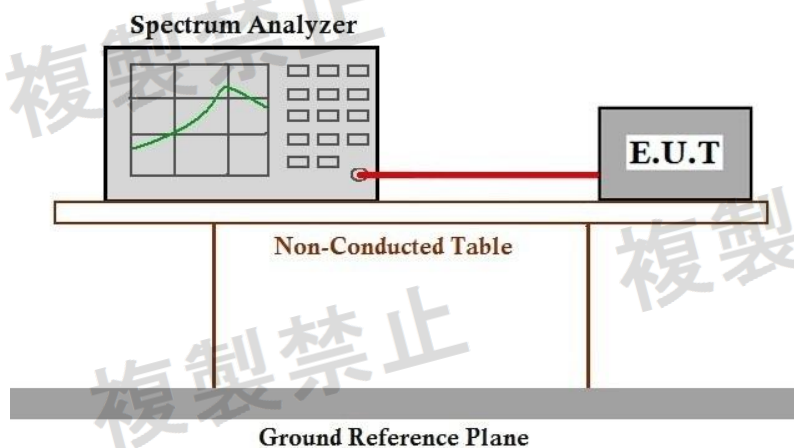
Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1010 mbar

7.5.2 Test Mode Description

Pre-scan / Final test	Mode Code	Description
Final test	01	RX_Keep the EUT in receiving mode

7.5.3 Test Setup Diagram



7.5.4 Measurement Procedure and Data

1. Test Conditions:

Spectrum Analyzer is used for measurement.

2. EUT conditions:

Modulation/Spread/Hopping ON

For equipment using diffusion code, set to the test diffusion code and modulate with standard coding test signal.

3. Spectrum Analyzer conditions:

Step 1

All spurious are measured from 30 MHz to 13 GHz by peak mode.

Step 2

IF the value measured by Step1 is 2 dB or less, measure in average mode.

Test setup for Step 1:

Frequency: 30 MHz - 2400 MHz , 2483.5 MHz -13 GHz

RBW 100 kHz (30 - 1GHz) , 1 MHz (over 1GHz)

VBW 100 kHz (30 - 1GHz) , 1 MHz (over 1GHz)

Sweep Time Auto

detector mode Positive peak

Indication mode Max hold

Test setup for Step 2:

Frequency: Spurious Frequency

Span 0 Hz

RBW 100 kHz (30 - 1GHz) , 1 MHz (over 1GHz)

VBW 100 kHz (30 - 1GHz) , 1 MHz (over 1GHz)

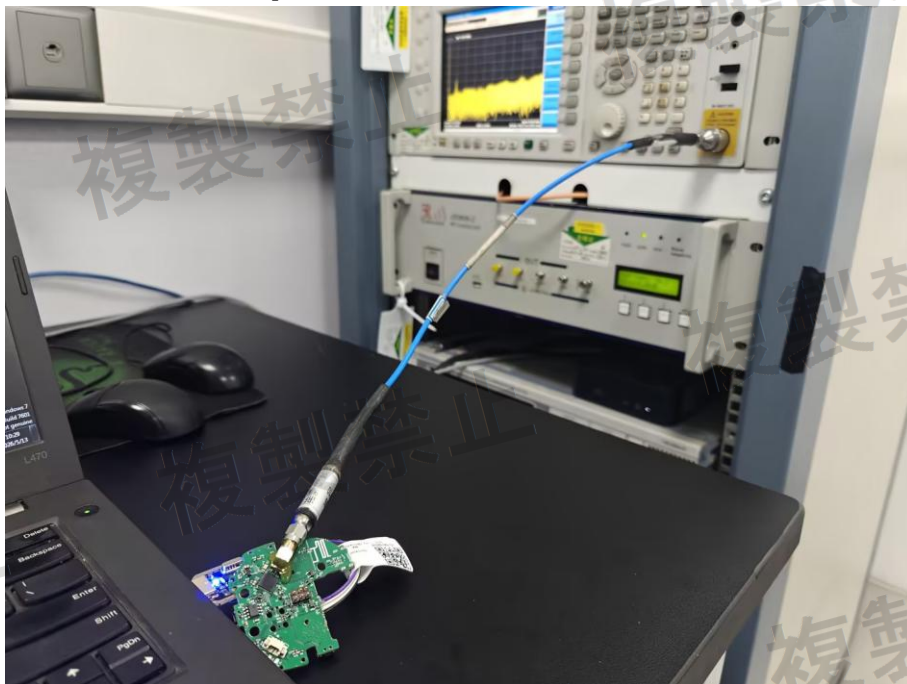
Sweep Time Auto

detector mode Sample

Indication mode Max hold

Please Refer to Appendix for Details

8 Test Setup Photo



9 EUT Constructional Details (EUT Photos)



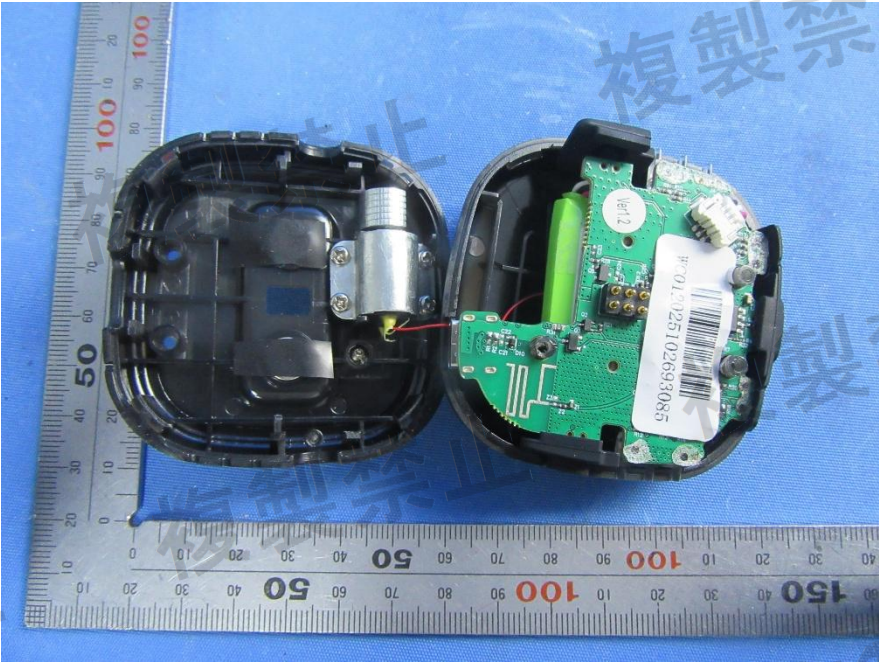


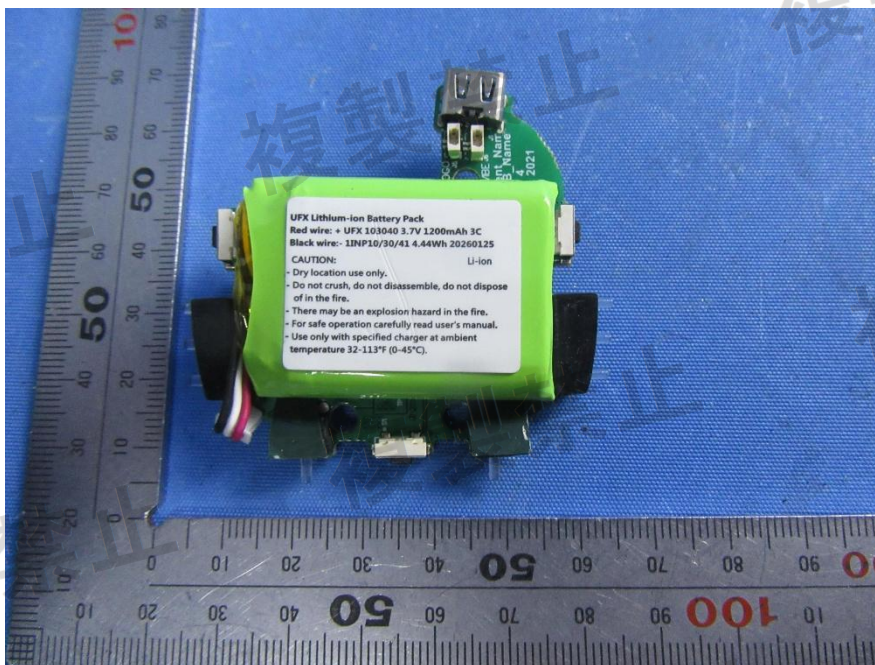
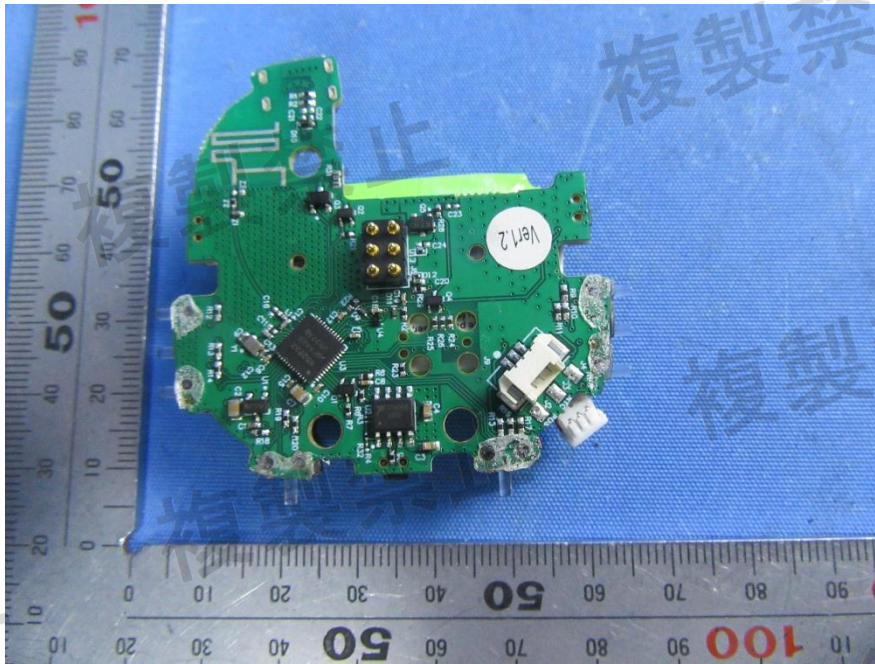












10 Appendix

1. Frequency Error

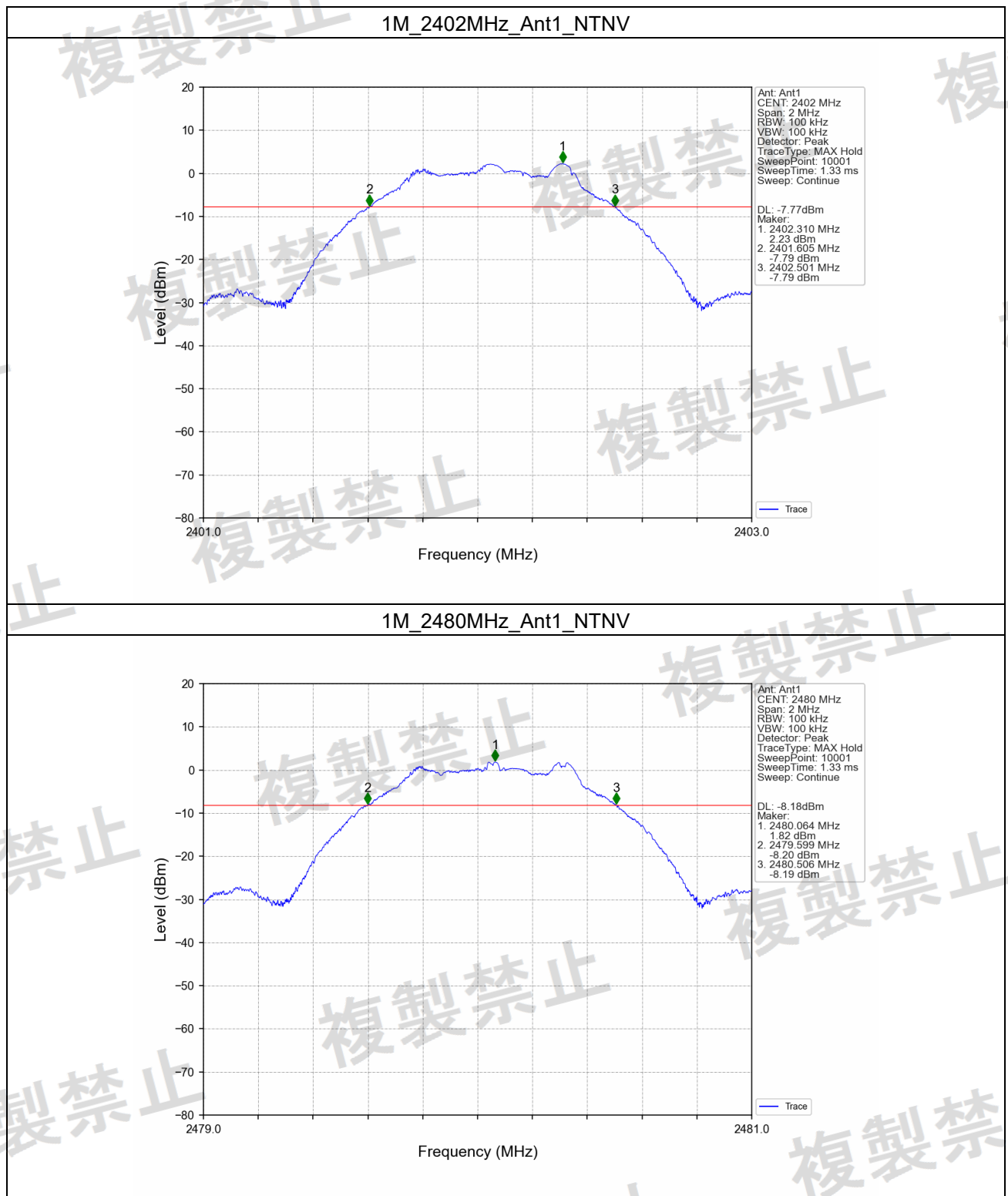
1.1 Test Result

1.1.1 Ant1

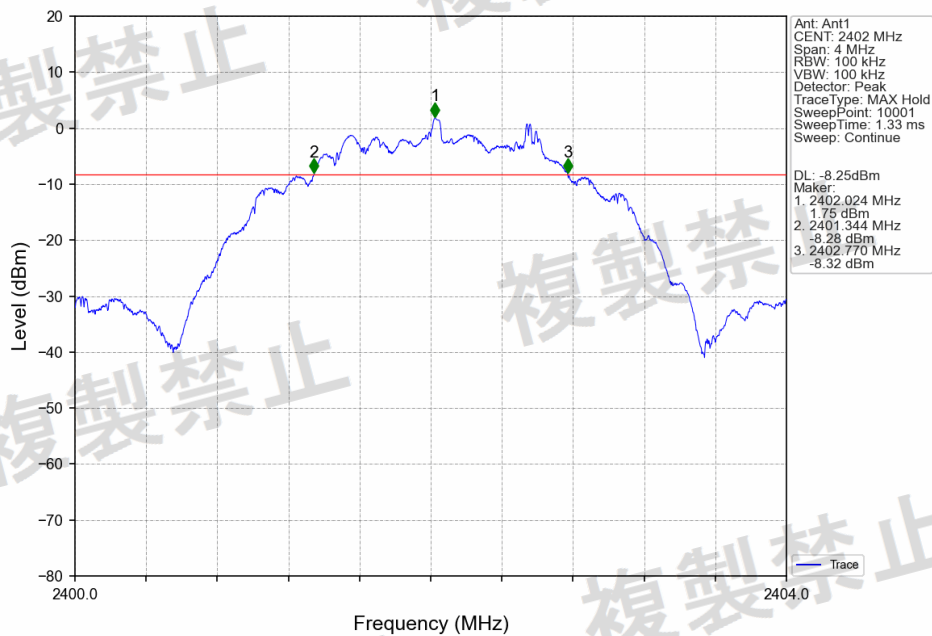
Ant1							
ENV	Mode	TX Type	Frequency (MHz)	Measured Frequency (MHz)	Tolerance (ppm)		Verdict
					Result	Limit	
NTNV	1M	SISO	2402	2402.053	22.15	-50 to 50	Pass
			2480	2480.053	21.21	-50 to 50	Pass
	2M	SISO	2402	2402.057	23.90	-50 to 50	Pass
			2480	2480.058	23.47	-50 to 50	Pass

1.2 Test Graph

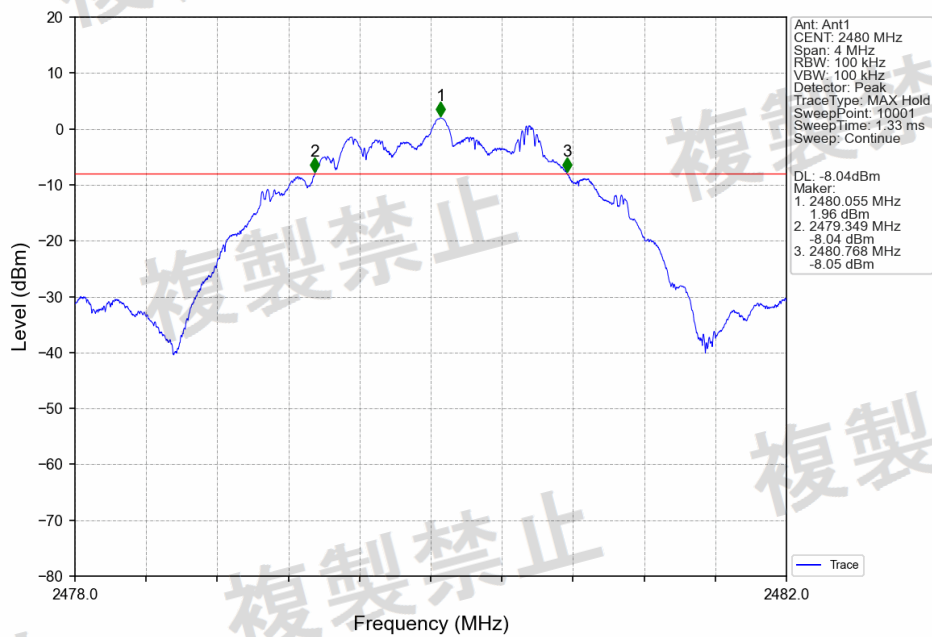
1.2.1 Ant1



2M_2402MHz_Ant1_NTNV



2M_2480MHz_Ant1_NTNV



2. Occupied Bandwidth

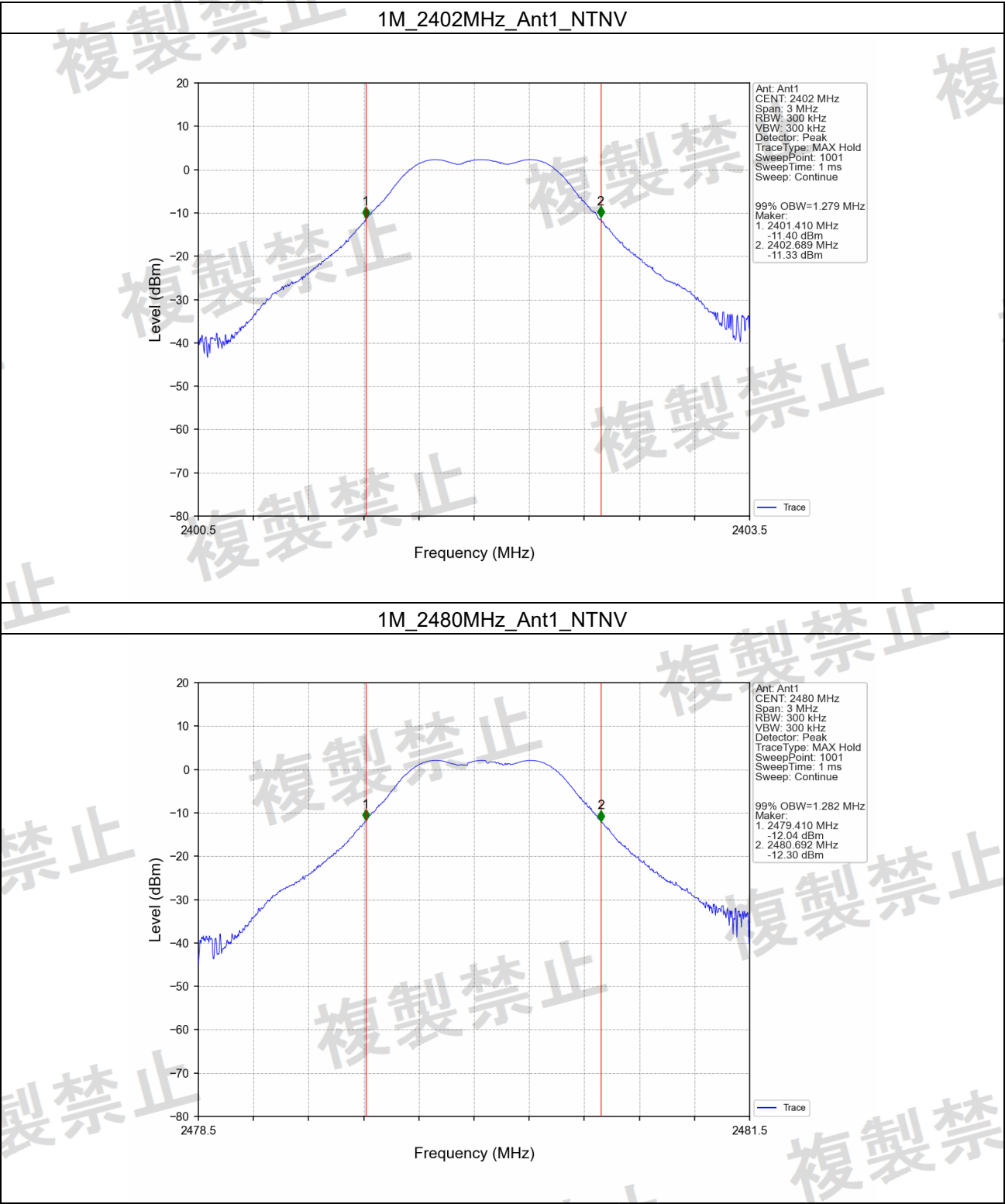
2.1 Test Result

2.1.1 OBW

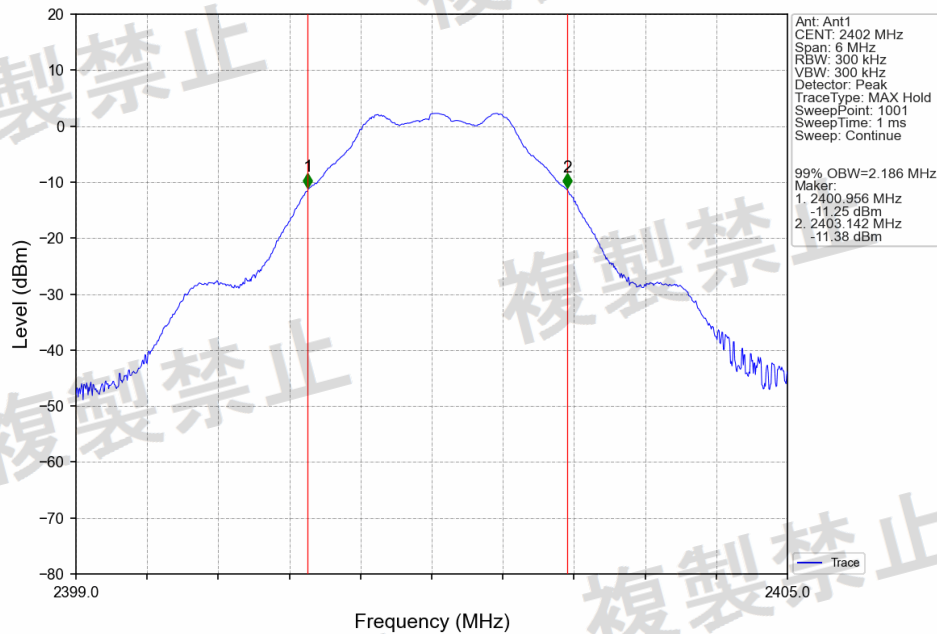
ENV	Mode	TX Type	Frequency (MHz)	99% Occupied Bandwidth (MHz)		Verdict
				ANT1	Limit	
NTNV	1M	SISO	2402	1.279	≤ 26	Pass
			2480	1.282	≤ 26	Pass
	2M	SISO	2402	2.186	≤ 26	Pass
			2480	2.192	≤ 26	Pass

2.2 Test Graph

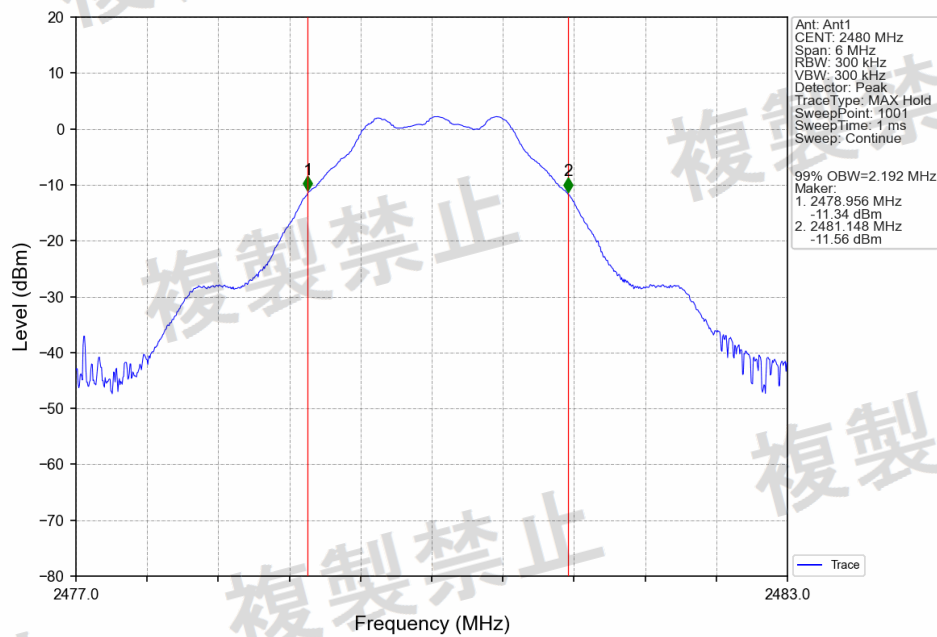
2.2.1 OBW



2M_2402MHz_Ant1_NTNV



2M_2480MHz_Ant1_NTNV



3. Antenna Power

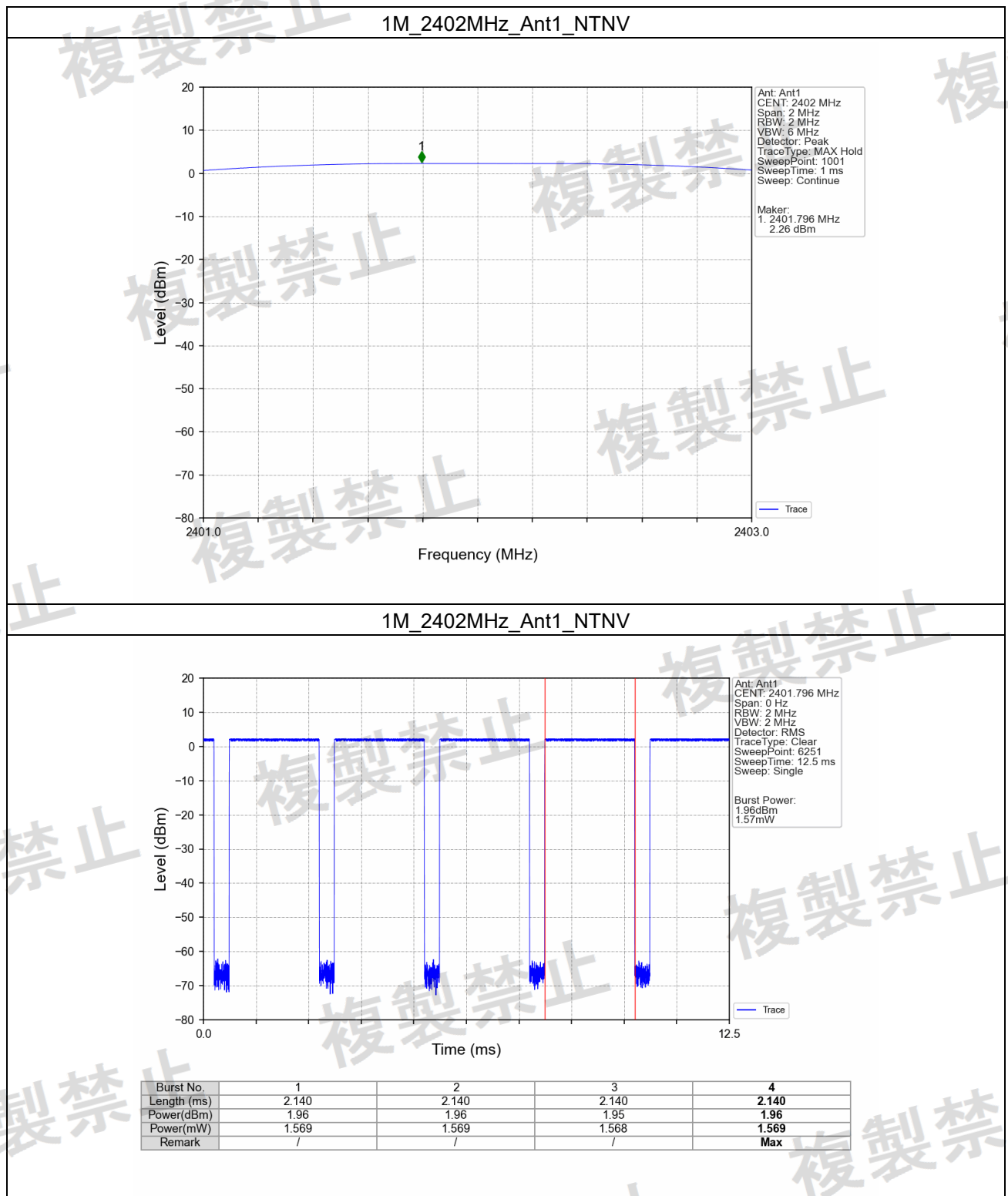
3.1 Test Result

3.1.1 Power

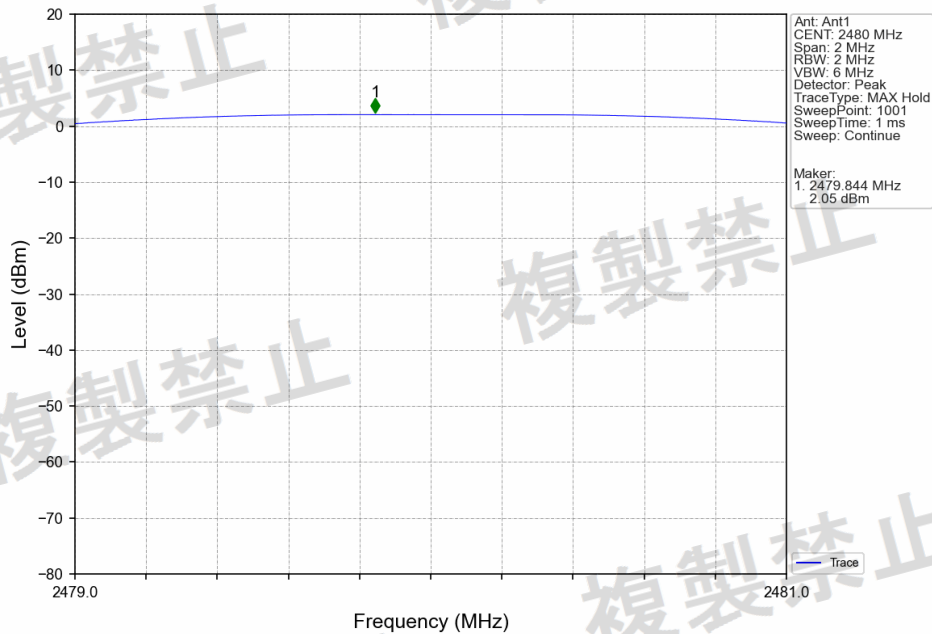
ENV	Mode	TX Type	Frequency (MHz)	ANT	Antenna Power (mW)		Nominal Power (mW)	Tolerance (%)		Verdict
					Measured	Limit		Measured	Limit	
NTNV	1M	SISO	2402	1	1.569	≤ 10.00	1.600	-1.94	≤ 20	Pass
			2480	1	1.508	≤ 10.00	1.500	0.53	≤ 20	Pass
	2M	SISO	2402	1	1.492	≤ 10.00	1.500	-0.53	≤ 20	Pass
			2480	1	1.426	≤ 10.00	1.400	1.86	≤ 20	Pass

3.2 Test Graph

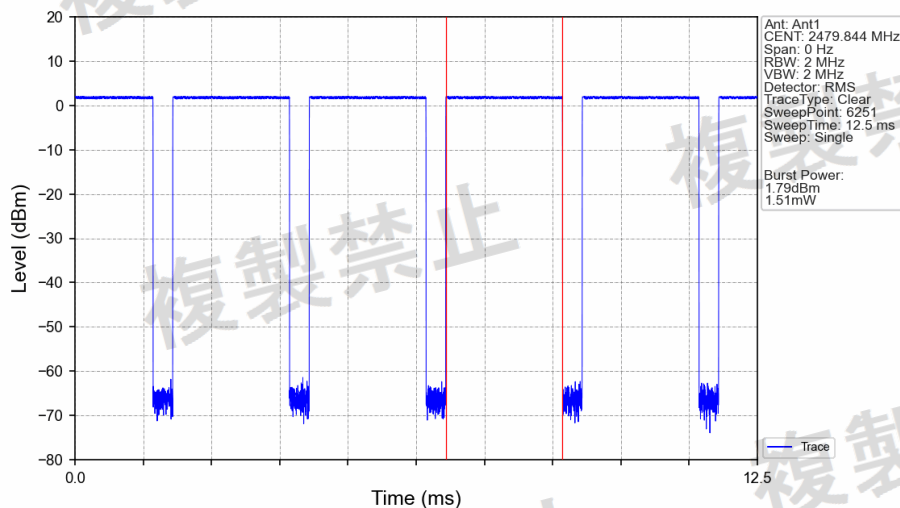
3.2.1 Power



1M_2480MHz_Ant1_NTNV

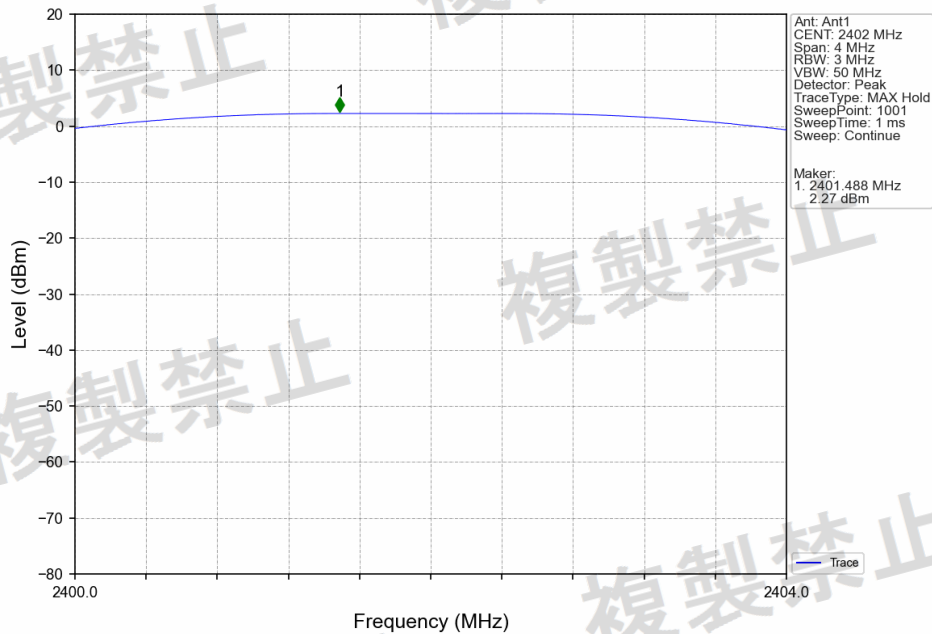


1M_2480MHz_Ant1_NTNV

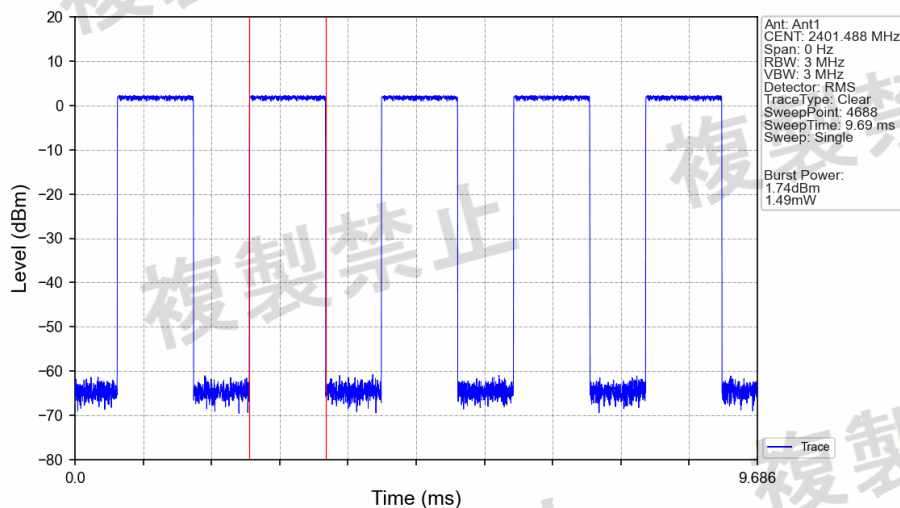


Burst No.	1	2	3	4
Length (ms)	2.138	2.138	2.138	2.138
Power(dBm)	1.78	1.78	1.79	1.78
Power(mW)	1.507	1.508	1.508	1.507
Remark	/	/	Max	/

2M_2402MHz_Ant1_NTNV

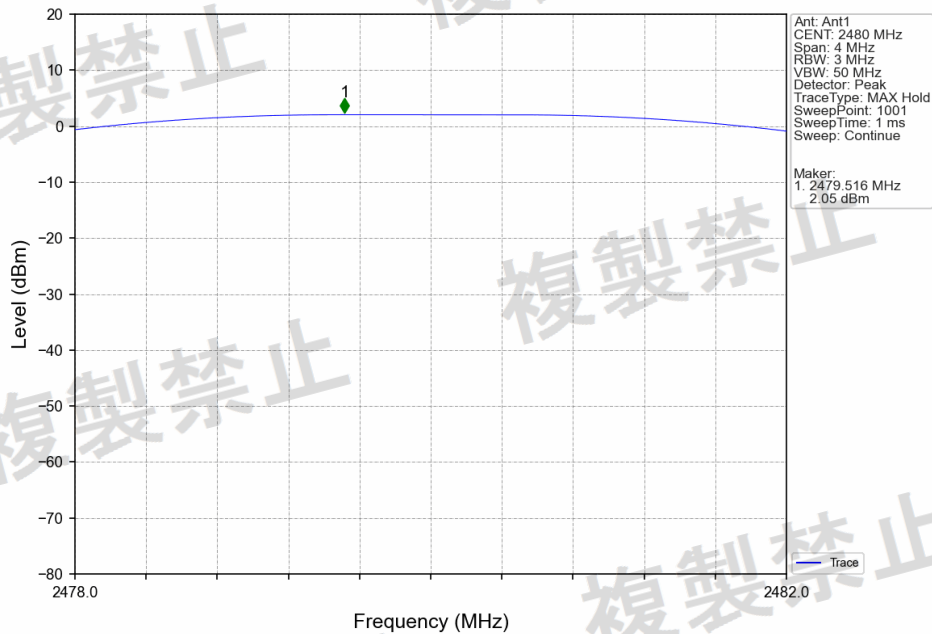


2M_2402MHz_Ant1_NTNV

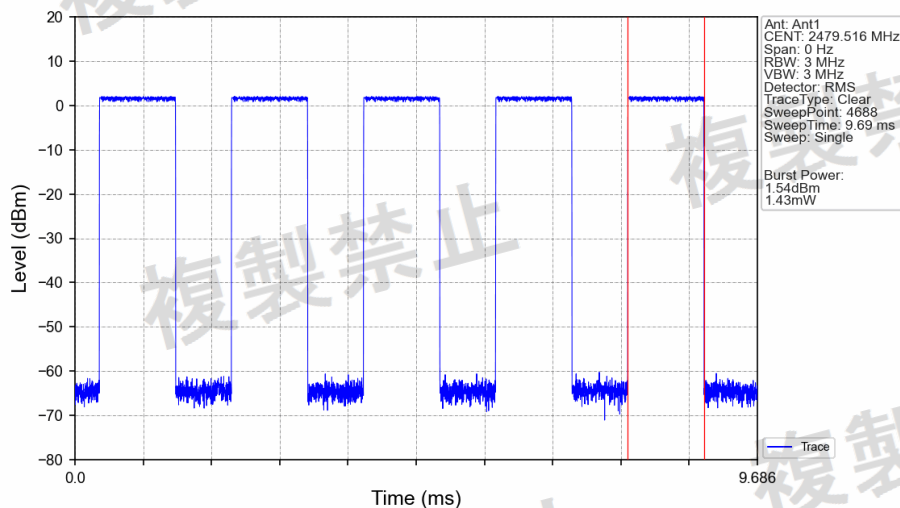


Burst No.	1	2	3	4	5
Length (ms)	1.081	1.081	1.081	1.083	1.081
Power(dBm)	1.74	1.74	1.74	1.73	1.74
Power(mW)	1.492	1.492	1.492	1.489	1.492
Remark	/	Max	/	/	/

2M_2480MHz_Ant1_NTNV



2M_2480MHz_Ant1_NTNV



Burst No.	1	2	3	4	5
Length (ms)	1.081	1.081	1.081	1.083	1.081
Power(dBm)	1.54	1.54	1.54	1.53	1.54
Power(mW)	1.425	1.426	1.426	1.423	1.426
Remark	/	/	/	/	Max

4. Spurious Emission Intensity

4.1 Test Result

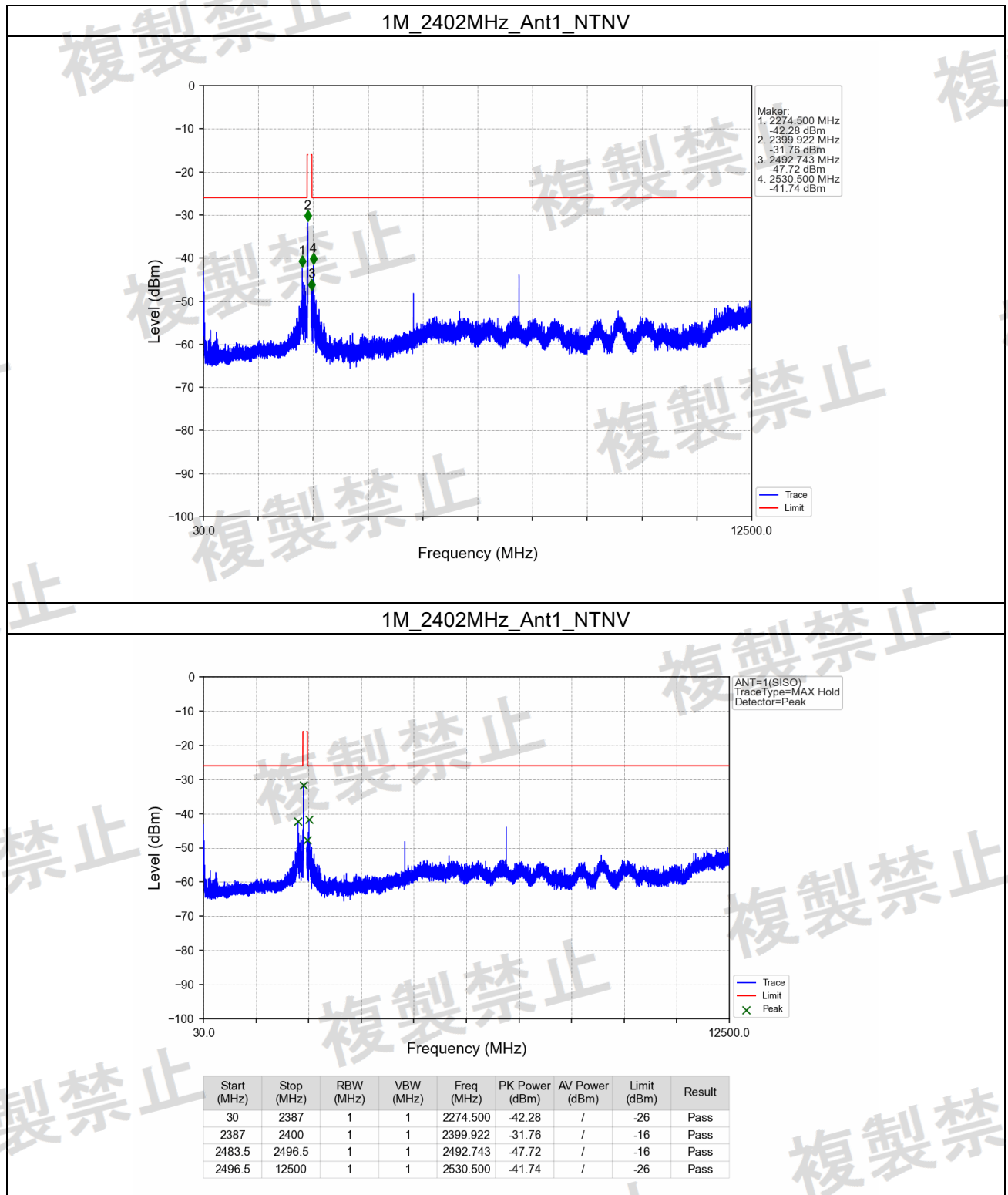
4.1.1 TxSe_NTNV

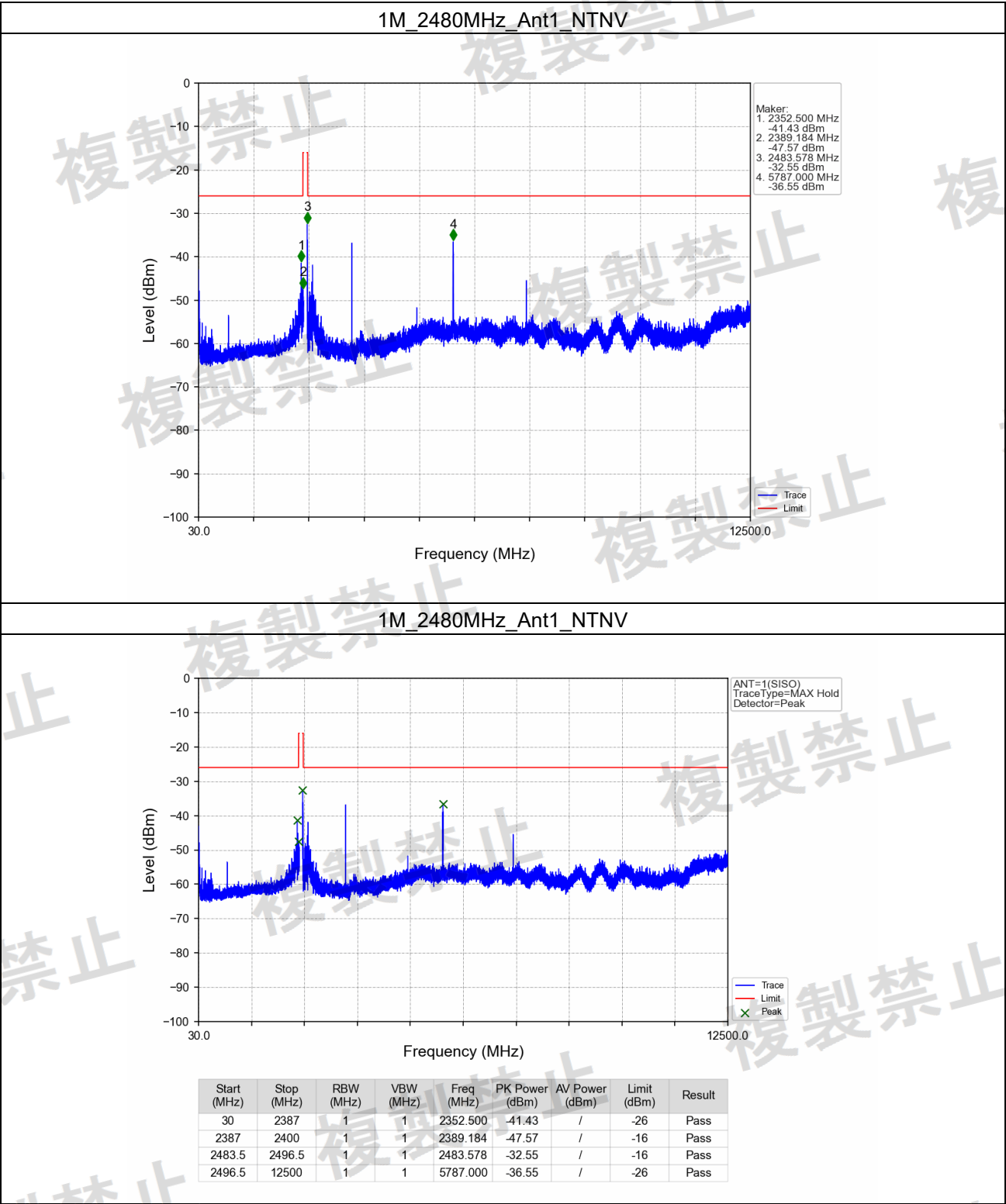
NTNV												
Mode	TX Type	Freq. (MHz)	ANT	Freq. Range		Marker					Limit (uW /MHz)	Verdict
				Start (MHz)	Stop (MHz)	Freq. (MHz)	PK Power (dBm /MHz)	PK Power (uW /MHz)	AV Power (dBm /MHz)	AV Power (uW /MHz)		
1M	SISO	2402	1	30	2387	2274.5	-42.28	0.059	/	/	2.5	Pass
				2387	2400	2399.922	-31.76	0.667	/	/	25	Pass
				2483.5	2496.5	2492.743	-47.72	0.017	/	/	25	Pass
				2496.5	12500	2530.5	-41.74	0.067	/	/	2.5	Pass
		2480	1	30	2387	2352.5	-41.43	0.072	/	/	2.5	Pass
				2387	2400	2389.184	-47.57	0.017	/	/	25	Pass
				2483.5	2496.5	2483.578	-32.55	0.556	/	/	25	Pass
				2496.5	12500	5787	-36.55	0.221	/	/	2.5	Pass
2M	SISO	2402	1	30	2387	2274.5	-42.10	0.062	/	/	2.5	Pass
				2387	2400	2399.987	-20.21	9.528	/	/	25	Pass
				2483.5	2496.5	2492.73	-47.67	0.017	/	/	25	Pass
				2496.5	12500	2531	-41.53	0.070	/	/	2.5	Pass
		2480	1	30	2387	2352	-41.68	0.068	/	/	2.5	Pass
				2387	2400	2391.602	-48.02	0.016	/	/	25	Pass
				2483.5	2496.5	2483.526	-32.70	0.537	/	/	25	Pass
				2496.5	12500	2609	-42.45	0.057	/	/	2.5	Pass

Note: The measurement just shows the test results, expressed in dBm units, which has the same meaning as uW/MHz.

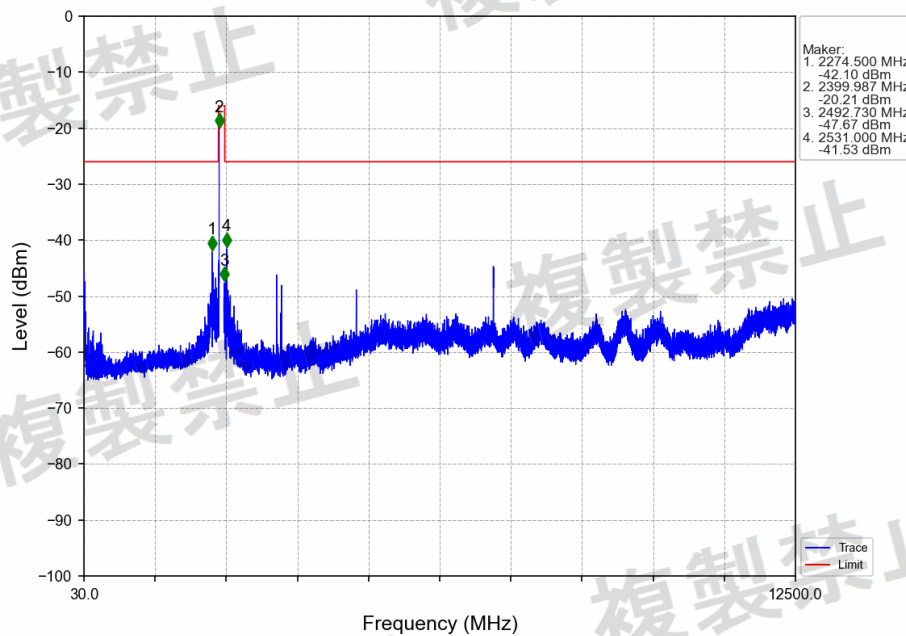
4.2 Test Graph

4.2.1 TxSe_NTNV

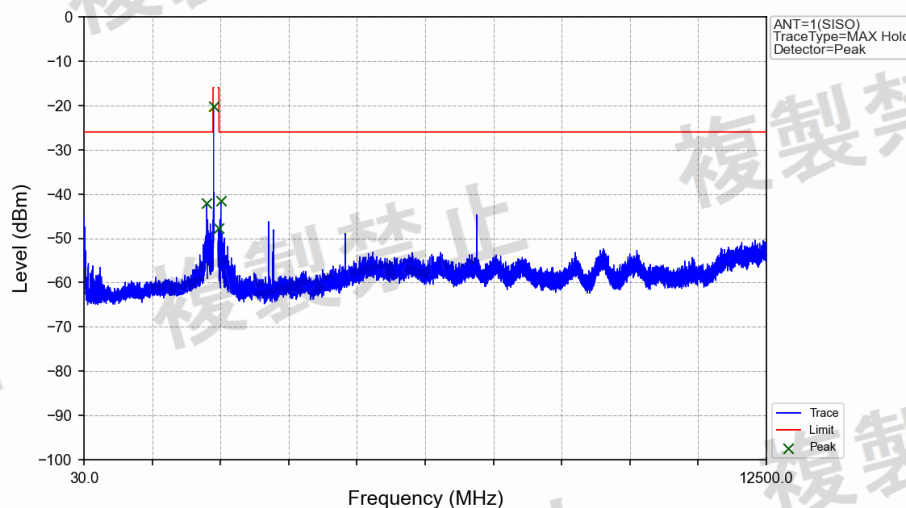




2M_2402MHz_Ant1_NTNV

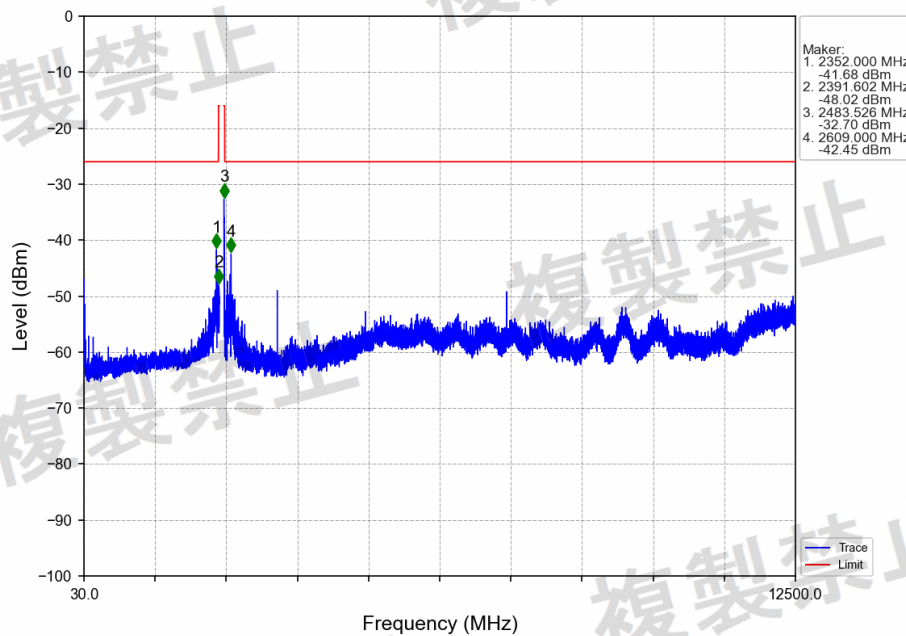


2M_2402MHz_Ant1_NTNV

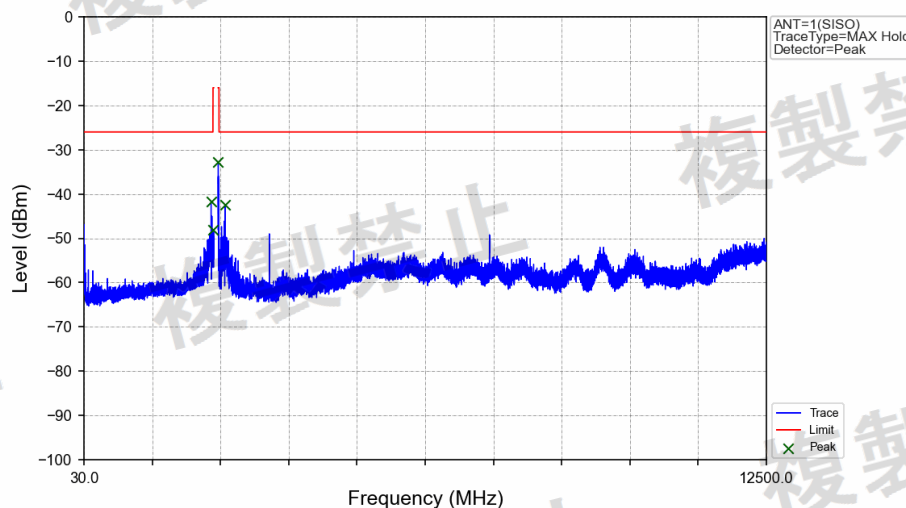


Start (MHz)	Stop (MHz)	RBW (MHz)	VBW (MHz)	Freq (MHz)	PK Power (dBm)	AV Power (dBm)	Limit (dBm)	Result
30	2387	1	1	2274.500	-42.10	/	-26	Pass
2387	2400	1	1	2399.987	-20.21	/	-16	Pass
2483.5	2496.5	1	1	2492.730	-47.67	/	-16	Pass
2496.5	12500	1	1	2531.000	-41.53	/	-26	Pass

2M_2480MHz_Ant1_NTNV



2M_2480MHz_Ant1_NTNV



Start (MHz)	Stop (MHz)	RBW (MHz)	VBW (MHz)	Freq (MHz)	PK Power (dBm)	AV Power (dBm)	Limit (dBm)	Result
30	2387	1	1	2352.000	-41.68	/	-26	Pass
2387	2400	1	1	2391.602	-48.02	/	-16	Pass
2483.5	2496.5	1	1	2483.526	-32.70	/	-16	Pass
2496.5	12500	1	1	2609.000	-42.45	/	-26	Pass

5. Secondary Radiated Emission

5.1 Test Result

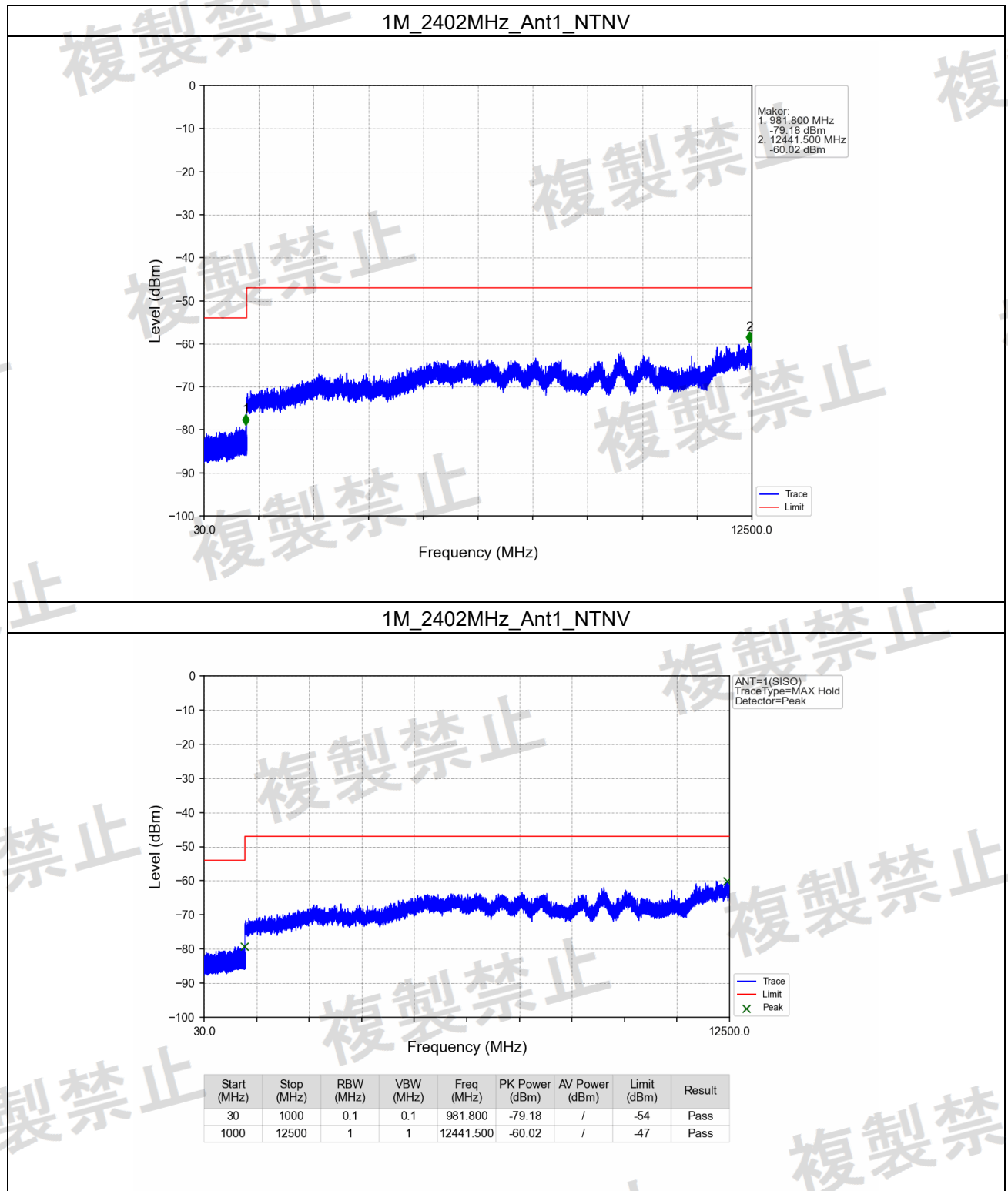
5.1.1 RxSe_NTNV

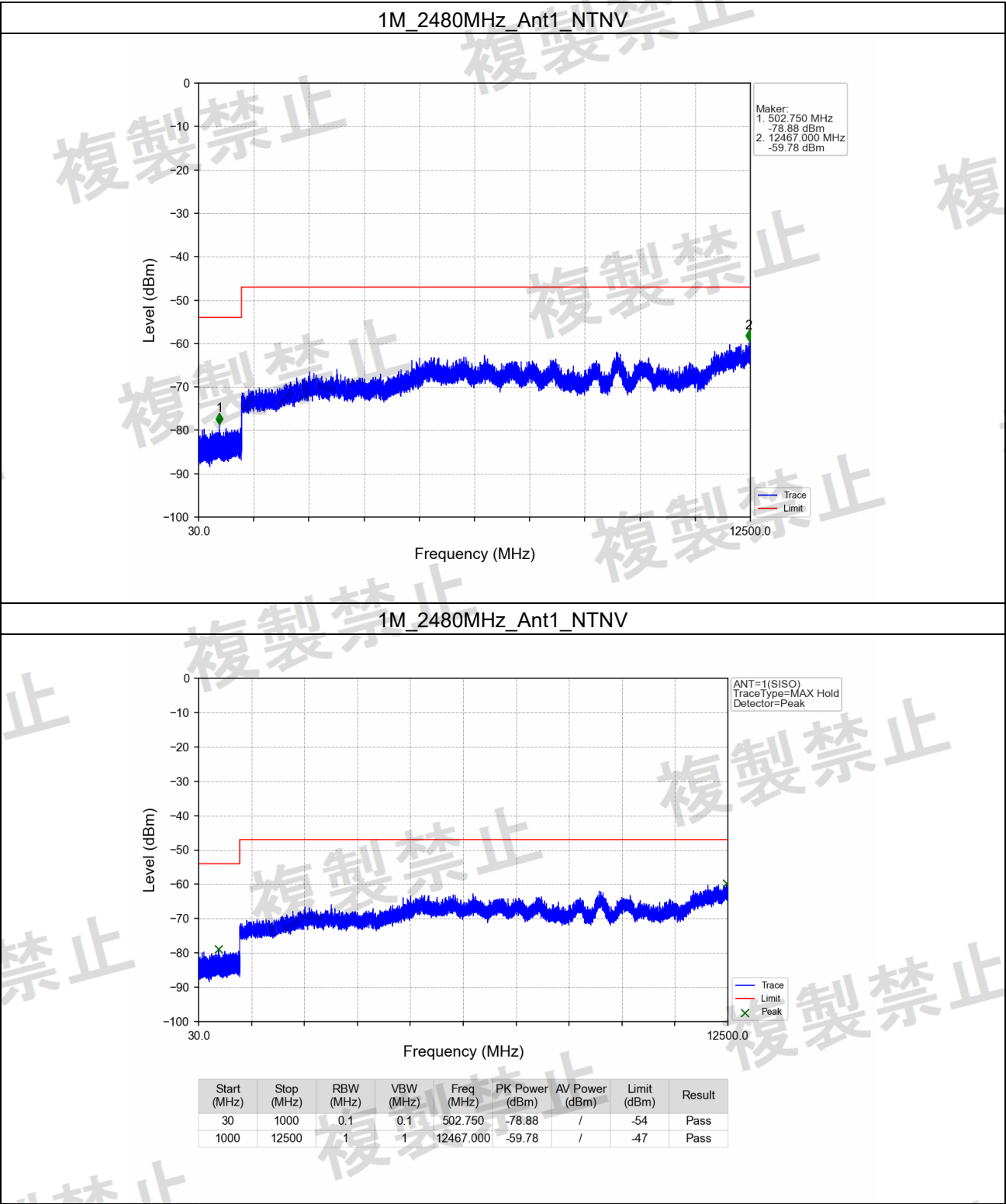
NTNV												
Mode	TX Type	Freq. (MHz)	ANT	Freq. Range		Marker					Limit (nW)	Verdict
				Start (MHz)	Stop (MHz)	Freq. (MHz)	PK Power (dBm)	PK Power (nW)	AV Power (dBm)	AV Power (nW)		
1M	SISO	2402	1	30	1000	981.8	-79.18	0.012	/	/	4	Pass
				1000	12500	12441.5	-60.02	0.995	/	/	20	Pass
		2480	1	30	1000	502.75	-78.88	0.013	/	/	4	Pass
				1000	12500	12467	-59.78	1.052	/	/	20	Pass
2M	SISO	2402	1	30	1000	922.2	-78.98	0.013	/	/	4	Pass
				1000	12500	12432	-59.03	1.250	/	/	20	Pass
		2480	1	30	1000	847.6	-78.35	0.015	/	/	4	Pass
				1000	12500	12435.5	-59.46	1.132	/	/	20	Pass

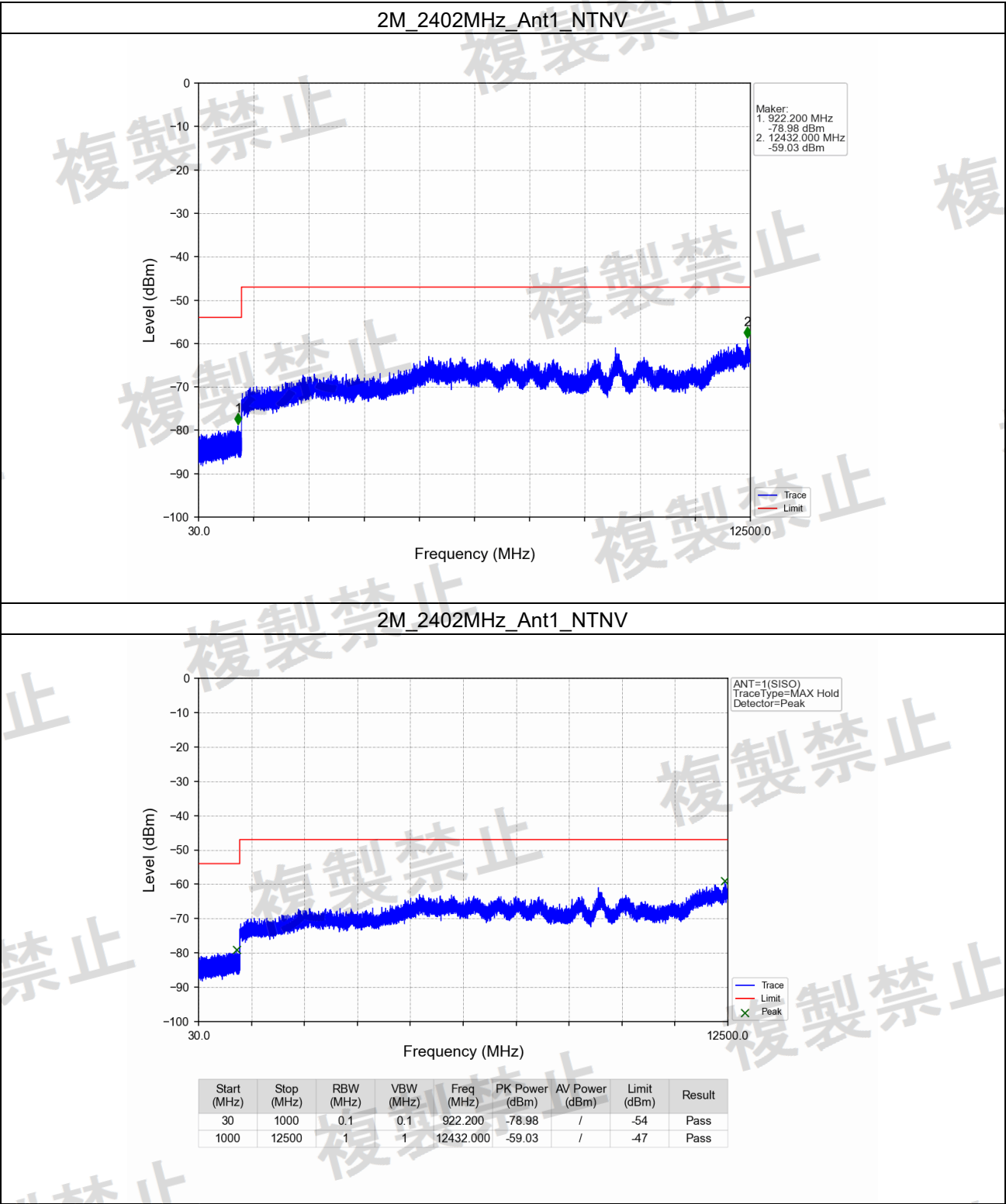
Note: The measurement just shows the test results, expressed in dBm units, which has the same meaning as nW.

5.2 Test Graph

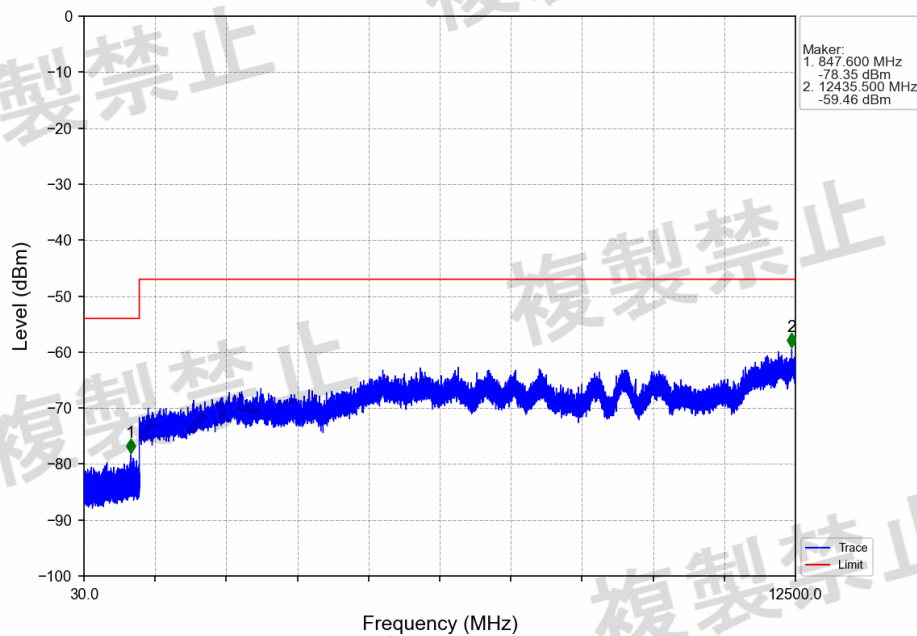
5.2.1 RxSe_NTNV



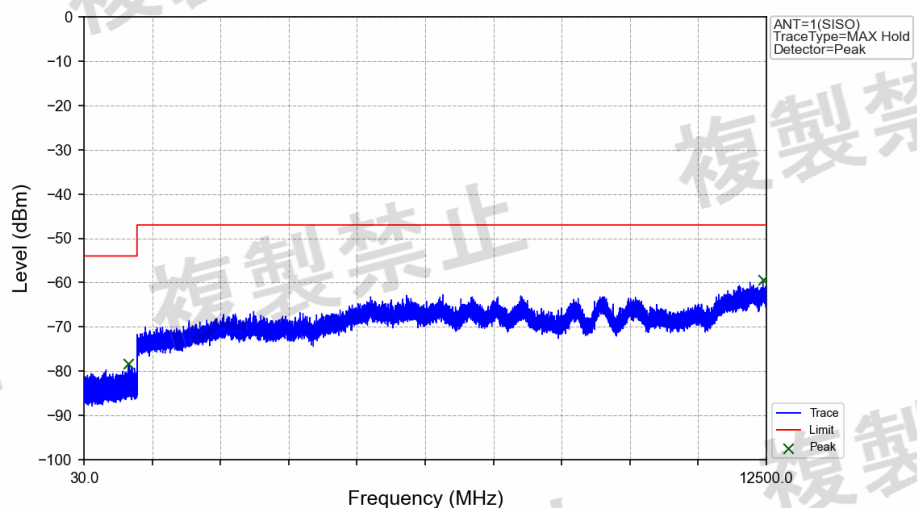




2M_2480MHz_Ant1_NTNV



2M_2480MHz_Ant1_NTNV



Start (MHz)	Stop (MHz)	RBW (MHz)	VBW (MHz)	Freq (MHz)	PK Power (dBm)	AV Power (dBm)	Limit (dBm)	Result
30	1000	0.1	0.1	847.600	-78.35	/	-54	Pass
1000	12500	1	1	12435.500	-59.46	/	-47	Pass